

MOSFET - N-Channel, Shielded Gate, POWERTRENCH®

150 V, 45 A, 12.4 mΩ

FDMS86255

Description

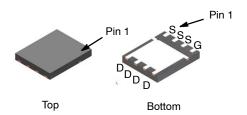
This N-Channel MOSFET is produced using **onsemi** advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

Features

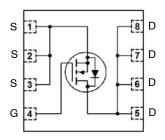
- Shielded Gate MOSFET Technology
- Max $R_{DS(on)} = 12.4 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 10 \text{ A}$
- Max $R_{DS(on)} = 15.5 \text{ m}\Omega$ at $V_{GS} = 6 \text{ V}$, $I_D = 8 \text{ A}$
- Advanced Package and Silicon Combination for Low R_{DS(on)} and High Efficiency
- Next Generation Enhanced Body Diode Technology, Engineered for Soft Recovery
- MSL1 Robust Package Design
- 100% UIL Tested
- RoHS Compliant
- These Device is Halogen Free

Applications

- OringFET / Load Switching
- Synchronous Rectification
- DC-DC Conversion



PQFN8 5X6, 1.27P CASE 483AG



MARKING DIAGRAM



\$Y = Logo

&Z = Assembly Location

&3 = Date Code (Year and Week)

&K = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

1

MOSFET MAXIMUM RATINGS $T_A = 25$ °C unless otherwise noted

Symbol	Parameter		Unit
V _{DS}	Drain to Source Voltage		V
V_{GS}	Gate to Source Voltage		V
I _D	Drain Current Continuous, T _C = 25°C		Α
	Continuous, T _A = 25°C (Note 1a)		
	Pulsed (Note 4)		
E _{AS}	Single Pulse Avalanche Energy (Note 3)		mJ
P_{D}	Power Dissipation, T _C = 25°C		W
	Power Dissipation, T _A = 25°C (Note 1a)		
T _{J,} T _{STG}	Operating and Storage Junction Temperature Range		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter		Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	1.1	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	45	

ELECTRICAL CHARACTERISTICS $T_A = 25^{\circ}C$ unless otherwise noted

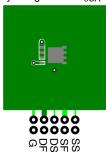
Symbol	Parameter	Test Con	ditions	Min.	Тур.	Max.	Unit
OFF CHARACTERISTICS							
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0$	$I_D = 250 \mu\text{A}, V_{GS} = 0 \text{V}$		-	-	V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, reference	d to 25°C	-	109	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 120 \text{ V}, V_{GS} = 0$	V	-	_	1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0$	V	-	-	±100	nA
ON CHARA	CTERISTICS						_
VGS(th)	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu$	A	2.0	3.0	4.0	V
$\Delta VGS(th)$ ΔT_J	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, reference	d to 25°C	_	-11	-	mV/°C
R _{DS(ON)}	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	as · B		9.5	12.4	mΩ
		V _{GS} = 6 V, I _D = 8 A			11.5	15.5	
		$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A},$	T _J = 125°C	-	19	25	
9FS	Forward Transconductance	V _{DS} = 5 V, I _D = 10 A		-	35	_	S
DYNAMIC CHARACTERISTICS							
C _{ISS}	Input Capacitance	V _{DS} = 75 V, V _{GS} = 0 V,		-	3200	4480	pF
C _{OOS}	Output Capacitance	f = 1 MHz		-	291	410	pF
Crss	Reverse Transfer Capacitance			-	11	20	pF
R_{g}	Gate Resistance			0.1	0.7	2.1	Ω
SWITCHING	CHARACTERISTICS						
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 75 \text{ V}, I_D = 10 \text{ A},$	V _{DD} = 75 V, I _D = 10 A,		21	34	ns
t _r	Rise Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		-	4.5	10	ns
t _{d(off)}	Turn-Off Delay Time			-	28	45	ns
t _f	Fall Time			-	6.2	12	ns
Qg	Total Gate Charge	V _{GS} = 0 V to 10 V	V _{DD} = 75 V,	-	45	63	nC
Qg	Total Gate Charge	V _{GS} = 0 V to 6 V		-	29	41	nC

ELECTRICAL CHARACTERISTICS (continued) $T_A = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit		
	SWITCHING CHARACTERISTICS							
Qgs	Gate to Source Charge		-	14	_	nC		
Qgd	Qgd Gate to Drain "Miller" Charge		-	8.8	-	nC		
DRAIN-SO	DRAIN-SOURCE DIODE CHARACTERISTICS							
V _{SD} Source to Drain Diode Forward		V _{GS} = 0 V, I _S = 1.9 A (Note 2)	-	0.7	1.2	V		
	Voltage	V _{GS} = 0 V, I _S = 10 A (Note 2)	-	0.8	1.3			
t _{rr}	Reverse Recovery Time	I _F = 10 A, di/dt = 100 A/μs	-	87	139	ns		
Q _{rr}	Reverse Recovery Charge		-	165	264	nC		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. R_{θJA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{θJC} is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 45°C/W when mounted on a 1 in² pad of 2 oz copper.



b. 115°C/W when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.
 E_{AS} of 541 mJ is based on starting T_J = 25 °C, L = 3 mH, I_{AS} = 19 A, V_{DD} = 150 V, V_{GS} = 10 V. 100% tested at L = 0.1 mH, I_{AS} = 60 A.
 Pulse Id refers to Figure.11 Forward Bias Safe Operation Area.

TYPICAL CHARACTERISTICS T_J = 25°C unless otherwise noted

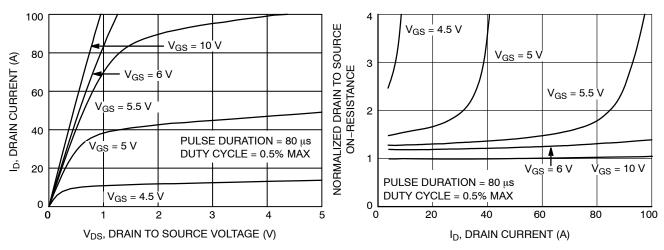


Figure 1. On-Region Characteristics

Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

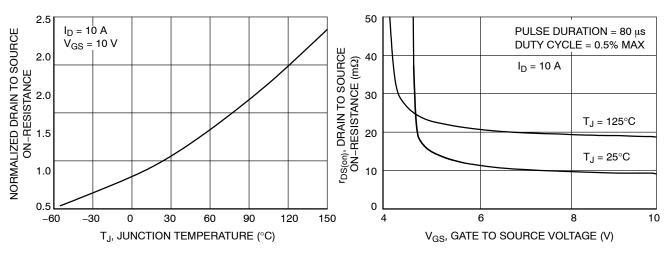


Figure 3. Normalized On–Resistance vs Junction Temperature

Figure 4. On-Resistance vs Gate to Source Voltage

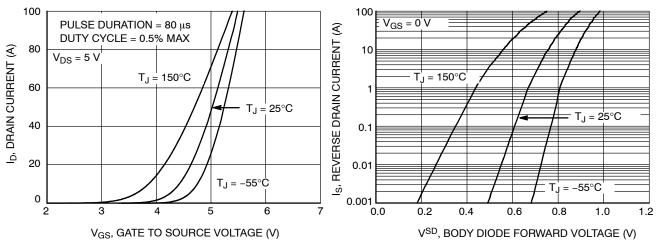


Figure 5. Transfer Characteristics

Figure 6. Source to Drain Diode Forward Voltage vs Source Current

TYPICAL CHARACTERISTICS (continued) T_J = 25°C unless otherwise noted

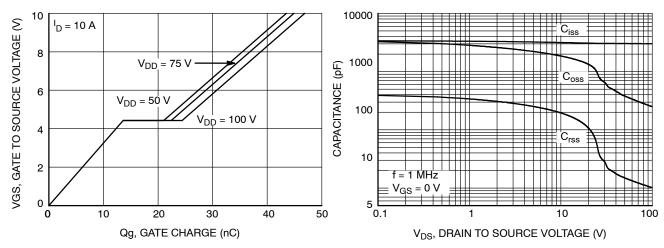


Figure 7. Gate Charge Characteristics

Figure 8. Capacitance vs Drain to Source Voltage

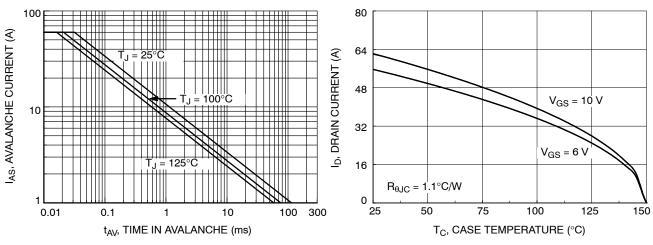


Figure 9. Unclamped Inductive Switching Capability

Figure 10. Maximum Continuous Drain Current vs Case Temperature

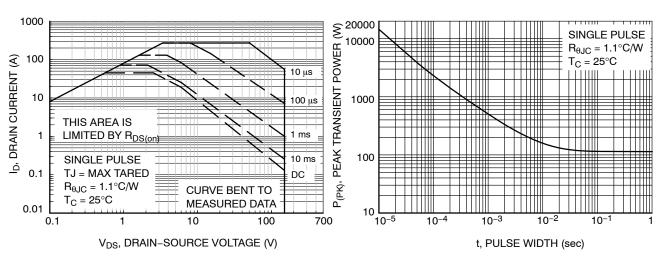


Figure 11. Forward Bias Safe Operating Area

Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued) $T_J = 25$ °C unless otherwise noted

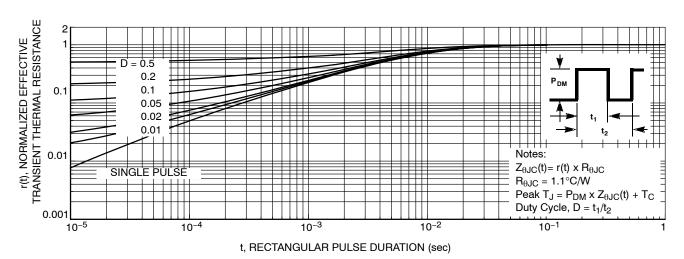


Figure 13. Transient Thermal Response Curve

ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Shipping [†]
FDMS86255	FDMS86255	PQFN8 (Halogen Free)	13"	12 mm	3000 / Tape and Reel

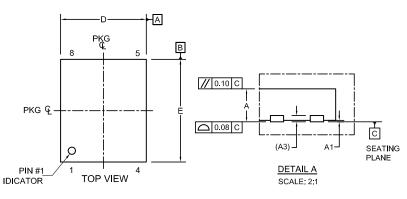
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

POWERTRENCH is registered trademark of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries.



PQFN8 5X6, 1.27P CASE 483AG ISSUE A

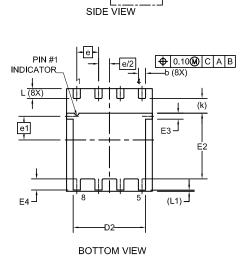
DATE 25 JUN 2021

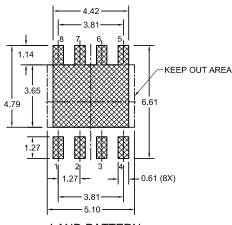


SEE DETAIL A

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.





LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

DIM	MILLIMETERS				
Dilvi	MIN.	NOM.	MAX.		
Α	0.90	1.00	1.10		
A1	0.00	-	0.05		
A3	(0.20 REF			
b	0.37	0.42	0.47		
D	4.90	5.00	5.10		
D2	4.13	4.23	4.33		
E	5.90	6.00	6.10		
E2	3.74	3.84	3.94		
E3	0.25	0.35	0.45		
E4	0.60	0.70	0.80		
е	1,27 BSC				
e/2	0.635 BSC				
e1	1.31 BSC				
k	0.86 REF				
L	0.47	0.57	0.67		
L1	0.08REF				

DOCUMENT NUMBER:	T NUMBER: 98AON13657G Electronic versions are uncontrolled except when accessed direct Printed versions are uncontrolled except when stamped "CONTRO"			
DESCRIPTION:	PQFN8 5X6, 1.27P		PAGE 1 OF 1	

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by ON Semiconductor manufacturer:

Other Similar products are found below:

614233C 648584F IRFD120 JANTX2N5237 FCA20N60_F109 FDZ595PZ 2SK2545(Q,T) 405094E 423220D TPCC8103,L1Q(CM MIC4420CM-TR VN1206L SBVS138LT1G 614234A 715780A NTNS3166NZT5G SSM6J414TU,LF(T 751625C BUK954R8-60E NTE6400 SQJ402EP-T1-GE3 2SK2614(TE16L1,Q) 2N7002KW-FAI DMN1017UCP3-7 EFC2J004NUZTDG ECH8691-TL-W FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE221 NTE222 NTE2384 NTE2903 NTE2941 NTE2945 NTE2946 NTE2960 NTE2967 NTE2969 NTE2976 NTE455 NTE6400A NTE2910 NTE2916 NTE2956 NTE2911 DMN2080UCB4-7 TK10A80W,S4X(S SSM6P69NU,LF DMP22D4UFO-7B